




<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/631,952	KLASS, EDGARDO F.	
	Examiner	Art Unit	
	Hai L. Nguyen	2816	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS	SUBCLASS				CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
327	165				327	141	166		
INTERNATIONAL CLASSIFICATION									
H	0	3	K	5/01					
				/					
				/					
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				/					
Hai L. Nguyen 1/31/2005 (Assistant Examiner) (Date)					TIMOTHY P. CALLAHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800				
 Appel Smith 2/7/05 (Legal Instruments Examiner) (Date)					Total Claims Allowed: 36 				

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant						<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47			
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